## Application/Control No. Applicant(s)/Patent Under Reexamination 10/686,234 YONEDA ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 David Vu 2828 **U.S. PATENT DOCUMENTS** Document Number Date Name Classification Country Code-Number-Kind Code MM-YYYY US-6,033,087 03-2000 Shozo et al. Α 362/244 \* В US-6,122,042 09-2000 Wunderman et al. 356/73 С US-6,400,101 06-2002 Biebl et al. 315/291

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